

STW77N65M5

N-channel 650 V, 0.033 Ω 69 A, MDmesh™ V Power MOSFET TO-247

Features

| Order code | V _{DSS} @T _{jmax.} | R _{DS(on)} max. | I _D |
|------------|---|--------------------------|----------------|
| STW77N65M5 | 710 V | < 0.038 Ω | 69 A |

- Higher V_{DSS} rating
- Higher dv/dt capability
- Excellent switching performance
- Easy to drive
- 100% avalanche tested

Application

Switching applications

Description

This device is a N-channel MDmesh™ V Power MOSFET based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low onresistance, which is unmatched among siliconbased Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

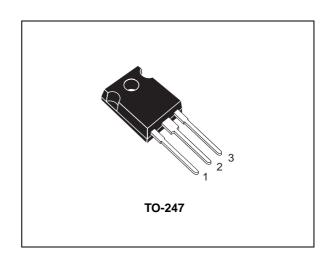


Figure 1. Internal schematic diagram

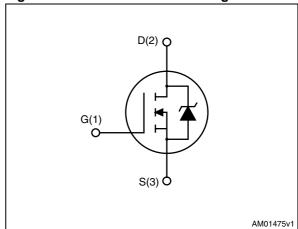


Table 1. Device summary

| Order code | Marking | Package | Packaging |
|------------|---------|---------|-----------|
| STW77N65M5 | 77N65M5 | TO-247 | Tube |

Contents STW77N65M5

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STW77N65M5 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|--------------------------------|---|-------|------|
| V_{GS} | Gate- source voltage | 25 | V |
| I _D | Drain current (continuous) at T _C = 25 °C | 69 | Α |
| I _D | Drain current (continuous) at T _C = 100 °C | 41.5 | Α |
| I _{DM} ⁽¹⁾ | Drain current (pulsed) 276 | | Α |
| P _{TOT} | Total dissipation at $T_C = 25$ °C 400 | | W |
| I _{AR} | Max current during repetitive or single pulse avalanche (pulse width limited by T _{JMAX}) | | Α |
| E _{AS} | Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V) | | mJ |
| dv/dt (2) | Peak diode recovery voltage slope 15 | | V/ns |
| T _{stg} | Storage temperature - 55 to 150 | | °C |
| T _j | Max. operating junction temperature | 150 | °C |

^{1.} Pulse width limited by safe operating area

Table 3. Thermal data

| Symbol | Parameter | Value | Unit |
|-----------------------|--|-------|------|
| R _{thj-case} | Thermal resistance junction-case max | 0.31 | °C/W |
| R _{thj-amb} | Thermal resistance junction-ambient max 50 | | °C/W |
| T _I | Maximum lead temperature for soldering purpose 300 | | °C |

^{2.} $I_{SD} \leq$ 69 A, di/dt = 400 A/ μ s, peak V_{DS} < $V_{(BR)DSS}$, V_{DD} = 400 V

Electrical characteristics STW77N65M5

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4. On /off states

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|----------------------|---|---|------|-------|----------|----------|
| V _{(BR)DSS} | Drain-source breakdown voltage | I _D = 1 mA, V _{GS} = 0 | 650 | | | V |
| I _{DSS} | Zero gate voltage drain current (V _{GS} = 0) | V_{DS} = Max rating V_{DS} = Max rating, T_{C} =125 °C | | | 1 100 | μA μA |
| I _{GSS} | Gate-body leakage current (V _{DS} = 0) | V _{GS} = ± 25 V | | | 100 | nA |
| V _{GS(th)} | Gate threshold voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 3 | 4 | 5 | V |
| R _{DS(on)} | Static drain-source on resistance | V _{GS} = 10 V, I _D = 34.5 A | | 0.033 | 0.038 | Ω |

Table 5. Dynamic

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|--|---|---|------|------------------|------|----------------|
| C _{iss} C _{oss} C _{rss} | Input capacitance Output capacitance Reverse transfer capacitance | V _{DS} = 100 V, f = 1 MHz, V _{GS} = 0 | - | 9800 200 6 | - | pF pF pF |
| C _{o(tr)} ⁽¹⁾ | Equivalent capacitance time related | $V_{GS} = 0$, $V_{DS} = 0$ to 520 V | - | 590 | - | pF |
| C _{o(er)} ⁽²⁾ | Equivalent capacitance energy related | $V_{GS} = 0$, $V_{DS} = 0$ to 520 V | - | 194 | - | pF |
| R _G | Intrinsic gate resistance | f = 1 MHz open drain | - | 1.2 | - | Ω |
| Q _g Q _{gs} Q _{gd} | Total gate charge Gate-source charge Gate-drain charge | $V_{DD} = 520 \text{ V}, I_{D} = 34.5 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see <i>Figure 16</i>) | - | 185 45 65 | - | nC nC nC |

^{1.} $C_{o(tr)}$ is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

^{2.} $C_{o(er)}$ is a constant capacitance value that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

Table 6. Switching times

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|---------------------|--------------------|---|------|------|------|------|
| t _{d(V)} | Voltage delay time | $V_{DD} = 400 \text{ V}, I_D = 40 \text{ A},$ | | 160 | | ns |
| t _{r(V)} | Voltage rise time | $R_G = 4.7 \Omega$, $V_{GS} = 10 V$ | | 22 | | ns |
| t _{f(i)} | Current fall time | (see Figure 17) | - | 20 | _ | ns |
| t _{c(off)} | Crossing time | (see Figure 20) | | 40 | | ns |

Table 7. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Тур. | Max. | Unit |
|--|--|--|------|-----------------|-----------|---------------|
| I _{SD} | Source-drain current Source-drain current (pulsed) | | - | | 69 276 | A A |
| V _{SD} (2) | Forward on voltage | I _{SD} = 69 A, V _{GS} = 0 | - | | 1.5 | V |
| t _{rr} Q _{rr} I _{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD} = 69 \text{ A},$ di/dt = 100 A/ μ s $V_{DD} = 100 \text{ V (see } Figure 17)$ | - | 570 14 48 | | ns µC A |
| t _{rr} Q _{rr} I _{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD} = 69 \text{ A},$ $di/dt = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V}, T_j = 150 \text{ °C}$ (see <i>Figure 17</i>) | - | 700 20 58 | | ns μC Α |

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: pulse duration = $300 \mu s$, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

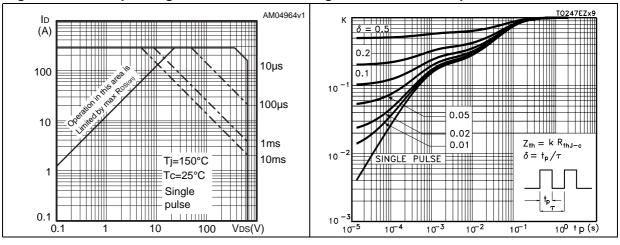


Figure 4. Output characteristics

Figure 5. Transfer characteristics

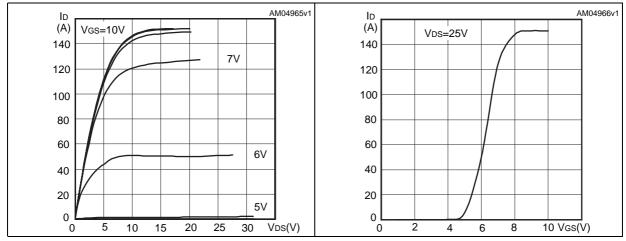


Figure 6. Gate charge vs gate-source voltage Figure 7. Static drain-source on resistance

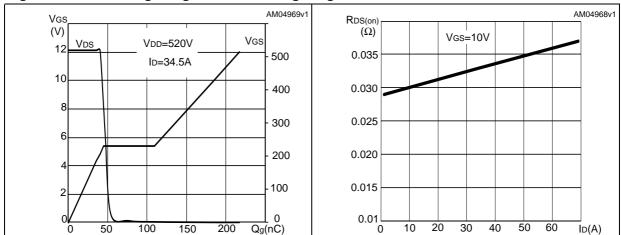


Figure 8. **Capacitance variations**

Figure 9. Output capacitance stored energy

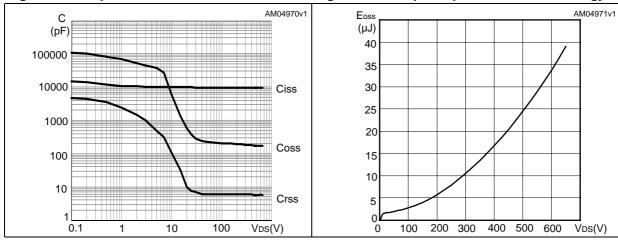


Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs vs temperature

temperature

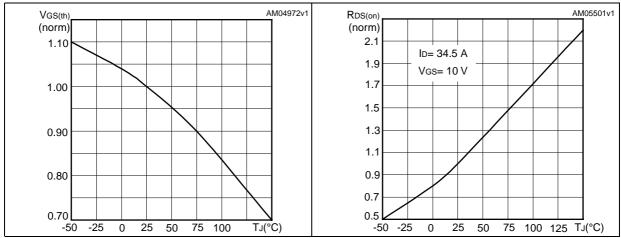
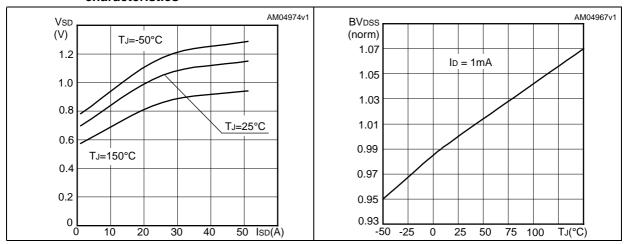


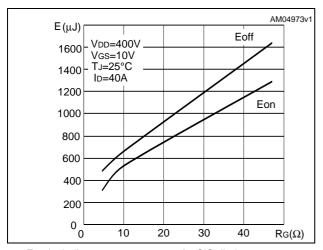
Figure 12. Source-drain diode forward characteristics

Figure 13. Normalized B_{VDSS} vs temperature



Electrical characteristics STW77N65M5

Figure 14. Switching losses vs gate resistance (1)



1. Eon including reverse recovery of a SiC diode

STW77N65M5 Test circuits

3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

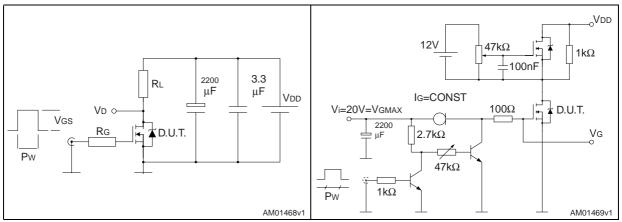


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

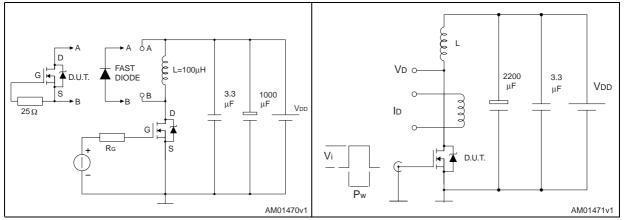
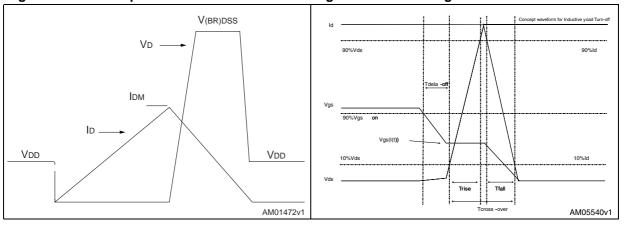


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



4 Package mechanical data

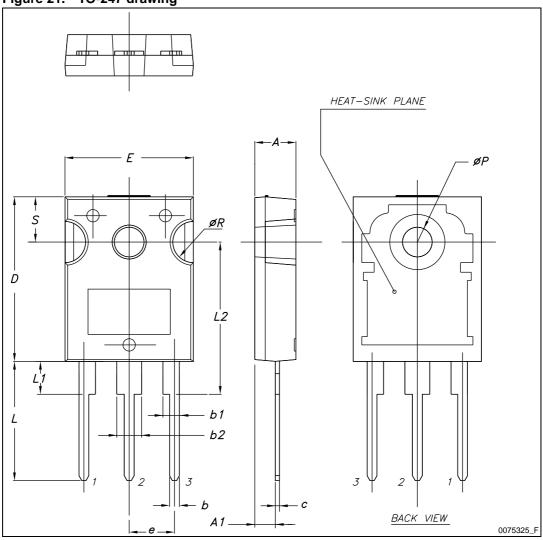
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Table 8. TO-247 mechanical data

| Dim | | mm | |
|------|-------|-------|-------|
| Dim. | Min. | Тур. | Max. |
| Α | 4.85 | | 5.15 |
| A1 | 2.20 | | 2.60 |
| b | 1.0 | | 1.40 |
| b1 | 2.0 | | 2.40 |
| b2 | 3.0 | | 3.40 |
| С | 0.40 | | 0.80 |
| D | 19.85 | | 20.15 |
| E | 15.45 | | 15.75 |
| е | | 5.45 | |
| L | 14.20 | | 14.80 |
| L1 | 3.70 | | 4.30 |
| L2 | | 18.50 | |
| ØP | 3.55 | | 3.65 |
| ØR | 4.50 | | 5.50 |
| S | | 5.50 | |

Figure 21. TO-247 drawing



STW77N65M5 Revision history

5 Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 20-Jan-2009 | 1 | First release. |
| 14-Jul-2009 | 2 | Document status promoted from preliminary data to datasheet. |
| 03-Feb-2011 | 3 | Section 2.1: Electrical characteristics (curves) has been updated. |

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